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Surface Resistance on collimator jaw material



Materials Surface treatments Measurements Results Conclusions

Materials

CFC materials

Graphite

Coating

	Company	Grade
Graphite	SGL	R 4550
		R8650
		R8710
		R8710Cu
		Sigrasic
	Росо	ZEE
		PLS
		FM
		DFP
CFC	Tatsuno	AC100
		AC200
		AC150
	SGL	1001Z
		1501Z
	Snecma	N11
		NB31

Surface treatment

- Coating after heat treatment 1000°C / 2h
- Side A : half CO₂ cleaning, half no cleaning Followed by 1 µm Copper coating
- Side B : half CO₂ cleaning, half no cleaning Followed by Ti flash and 1 µm Copper coating

Thickness of coating measured by: step profiler, x-ray fluorescence or weight. Average thickness

Measurements 1

Resistivity on a large sample:

 $\rho = V/I 2\pi s$

- $\boldsymbol{\rho} \text{ : resistivity}$
- s : point spacing
- V : potential between inner probes
- I : current through the outer pairs of probes

Measurements 2

Resistivity measurement (ASTM C 611 - 84):



Measurements 3

Contact Resistance influenced by -Geometry

- -Material and combination
- -Microstructure
- -Contact forces
- -Temperature

Results (bulk)

Graphite		Size	Orientation	Resistivity [$\mu \Omega$ m]	known values
				bakeout (1000°C for 2 h)	
				before	
SGL	R 4550	Prim.	iso	15	13
		Sec.	iso		
	R8650	Prim.	iso	15	14
	R8710	sample	iso	16	14
	R8710Cu	sample	iso	6	3
	Sigrasic				
Poco	ZEE		iso	44	
	PLS		iso		12.2
	FM		iso		12.4
	DFP		iso		15
CFC					
Tatsuno	AC100	Prim.	х-у	11-12.5	
	AC200	Prim.	Х	13.5-18	
		Sec.	х-у	14	
	AC150		х-у		
SGL	1001Z	sample	х-у		6
	1501Z	sample	х-у		6
Snecma	N11	"Prim."	х-у	6	
	NB31	samples	x-y-z	9	

Conclusions

- Bulk resistivity measurement correspond to literature (4 points)
- "surface"/bulk compared to beam effect?
- Contact resistance in case of coating and for RF-contacts / clamping structure?